

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10823161	FRANK, MICHAEL
Examiner	Art Unit	
Chen, Chia-Wei A	2622	

SEARCHED			
Class	Subclass	Date	Examiner
348	374	8/17/2007	Chen, Chia-Wei A
250	208.1	8/17/2007	Chen, Chia-Wei A
257	433	8/17/2007	Chen, Chia-Wei A

SEARCH NOTES			
Search Notes	Date	Examiner	
Attached EAST Search History	8/17/2007	Chen, Chia-Wei A	
Attached Inventor Name Search	8/17/2007	Chen, Chia-Wei A	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner